

**Search Notes**

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Examiner

Alex Liew

Applicant(s)/Patent under  
Reexamination

MOON ET AL.

Art Unit

2624

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/124-127 limited to text search	8/5/2007	AL
283/68-70 limited to text search	8/5/2007	AL
356/71 limited to text search	8/5/2007	AL
IEEE text search	8/5/2007	AL